

AONS66908

100V N-Channel AlphaSGT™

General Description

- Trench Power AlphaSGT[™] technology 100V
- Low R_{DS(ON)}
- Logic Level Driving
- Excellent QG x R_{DS(ON)}
- RoHS 2.0 and Halogen-Free Compliant

Applications

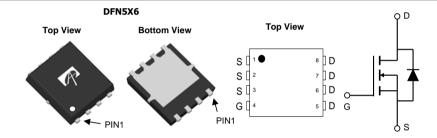
• High Frequency Switching and Synchronous Rectification.

Product Summary

 $\begin{array}{ll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 158A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 4.2 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 5.4 m\Omega \end{array}$

100% UIS Tested 100% Rg Tested





Orderable Part Number	Package Type	Form	Minimum Order Quantity
AONS66908	DFN 5x6	Tape & Reel	3000

Absolute	e Maximum Ratings	T _A =25°C	unless	othe	rwise r	noted
				_		

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain	T _C =25°C	I_	158	
Current	T _C =100°C	ID .	100	A
Pulsed Drain Current ^C		I _{DM}	335	
Continuous Drain Current	T _A =25°C		30	A
	T _A =70°C	IDSM	24	7
Avalanche Current ^C		I _{AS}	64	Α
Avalanche energy	L=0.1mH	E _{AS}	205	mJ
	T _C =25°C	P _D	208	W
Power Dissipation ^B	T _C =100°C	r _D	83	VV
	T _A =25°C	D	7.3	W
Power Dissipation ^A	T _A =70°C	P _{DSM}	4.7	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	14	17	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	55	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.45	0.6	°C/W	



Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC PARAMETERS							
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	100			V	
I _{DSS} Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V			1			
DSS	Zero Gate Voltage Drain Gurrent	T _J =55°	°C		5	μA	
I_{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm20V$			±100	nA	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.6	2.1	2.6	V	
		V _{GS} =10V, I _D =20A		3.5	4.2	mΩ	
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T _J =125°	°C	5.9	7.1	11122	
		V _{GS} =4.5V, I _D =20A		4.3	5.4	mΩ	
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A		117		S	
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V	
Is	Maximum Body-Diode Continuous Current				158	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance			5117		рF	
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =50V, f=1MHz		1127		pF	
C_{rss}	Reverse Transfer Capacitance	1		19		рF	
R_g	Gate resistance	f=1MHz	0.7	1.4	2.1	Ω	
SWITCHI	NG PARAMETERS						
Q _g (10V)	Total Gate Charge			69	97	nC	
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A		32	45	nC	
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =30V, I _D =20A		13		nC	
Q_{gd}	Gate Drain Charge	1		8		nC	
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =50V		96		nC	
t _{D(on)}	Turn-On DelayTime			12.5		ns	
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_{L} =2.5 Ω ,		6		ns	
t _{D(off)}	Turn-Off DelayTime	R_{GEN} =3 Ω		60		ns	
t _f	Turn-Off Fall Time]		11.5		ns	
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		40		ns	
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs		260		nC	

A. The value of R_{BJA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R_{BJA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO MAKE CHANGES TO PRODUCT SPECIFICATIONS WITHOUT NOTICE. IT IS THE RESPONSIBILITY OF THE CUSTOMER TO EVALUATE SUITABILITY OF THE PRODUCT FOR THEIR INTENDED APPLICATION. CUSTOMER SHALL COMPLY WITH APPLICABLE LEGAL REQUIREMENTS, INCLUDING ALL APPLICABLE EXPORT CONTROL RULES, REGULATIONS AND LIMITATIONS.

AOS' products are provided subject to AOS' terms and conditions of sale which are set forth at: http://www.aosmd.com/terms and conditions of sale

Rev.1.1: January 2024 **www.aosmd.com** Page 2 of 6

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $\rm T_{J(MAX)}\!\!=\!\!150^\circ\,$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

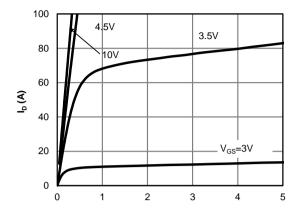
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

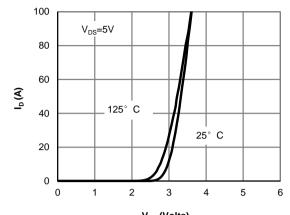
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



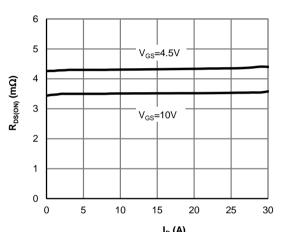
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $V_{\rm DS}$ (Volts) Figure 1: On-Region Characteristics (Note E)



V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



 ${\rm I_D}\left({\rm A} \right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

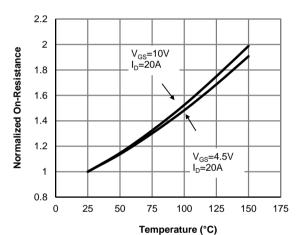
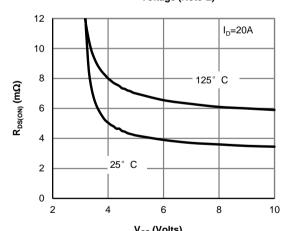
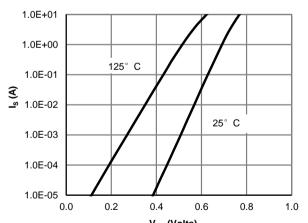


Figure 4: On-Resistance vs. Junction Temperature (Note E)



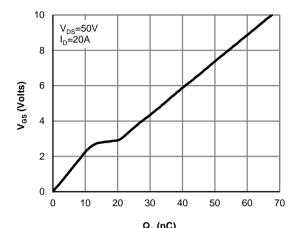
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



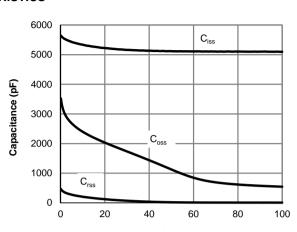
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



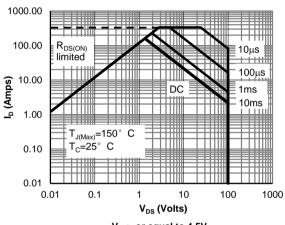
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



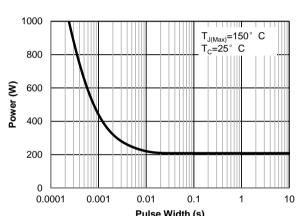
 ${\bf Q_g}$ (nC) Figure 7: Gate-Charge Characteristics



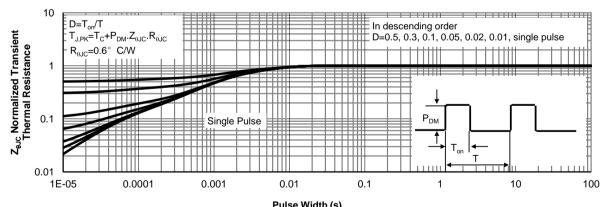
V_{DS} (Volts)
Figure 8: Capacitance Characteristics



V_{GS}> or equal to 4.5V Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



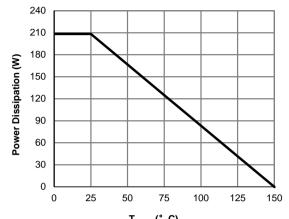
Pulse Width (s)
Figure 10: Single Pulse Power Rating Junction-toCase (Note F)



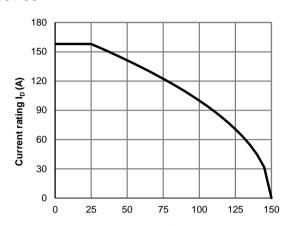
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



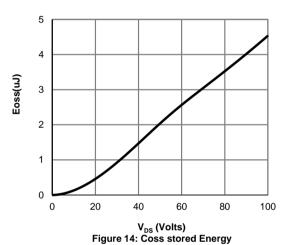
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

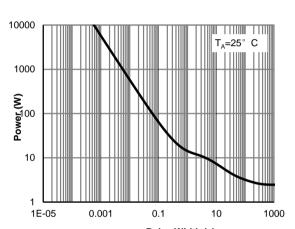


T_{CASE} (° C)
Figure 12: Power De-rating (Note F)

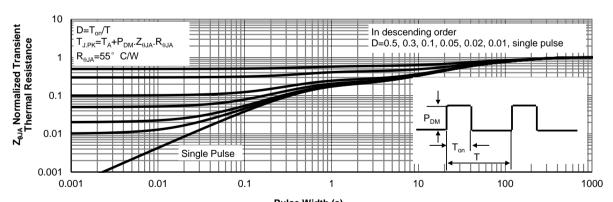


T_{CASE} (° C)
Figure 13: Current De-rating (Note F)





Pulse Width (s) Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

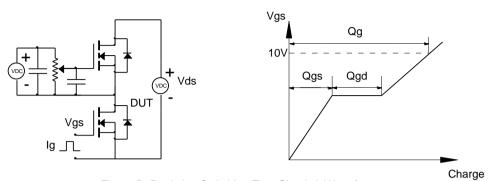


Figure B: Resistive Switching Test Circuit & Waveforms

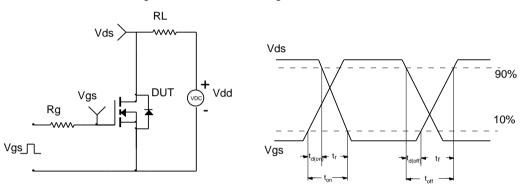


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

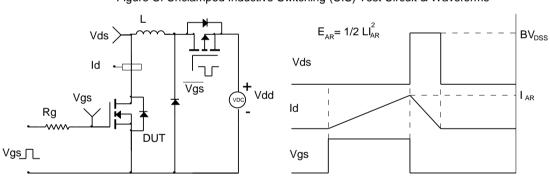
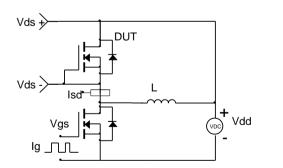
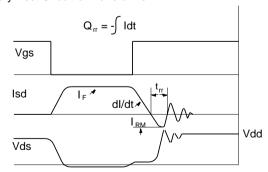


Figure D: Diode Recovery Test Circuit & Waveforms





Rev.1.1: January 2024 **www.aosmd.com** Page 6 of 6